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In re patent application of

Hamid K. Aghajan

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For: Two-Dimensional Scatter Plot
Technique for Defect Detection

Group Art Unit: 2621

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I hereby certify that this correspondence is being deposited on August 8, 2002 with the United States Postal Service as first class mail, with sufficient postage, in an envelope addressed to Commissioner for Patents, Washington, D.C. 20231.

Michael B. Einschlag
Michael B. Einschlag

August 8, 2002
Date of Signature

Commissioner for Patents
Washington, D.C. 20231

Sir:

This is in response to the outstanding Office Action mailed March 27, 2002. An Extension Petition is attached hereto to extend the time for responding by two (2) months from June 27, 2002 to and including August 27, 2002.